

Search Notes

Application/Control No.

10/501,180

Examiner

Bao Q. Truong

Applicant(s)/Patent under
Reexamination

LICK ET AL.

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	470	12/22/2006	BQT
362	553	12/22/2006	BQT
362	551		
362	471		
362	511		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
classification search, art in IDS.	12/22/2006	BQT